

Electronic Supporting Information for:

Layer-Dependent Optical Conductivity in Atomic Thin WS₂ by Reflection

Contrast Spectroscopy

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1. SEM analysis of as grown WS₂ islands on SiO₂/Si substrate

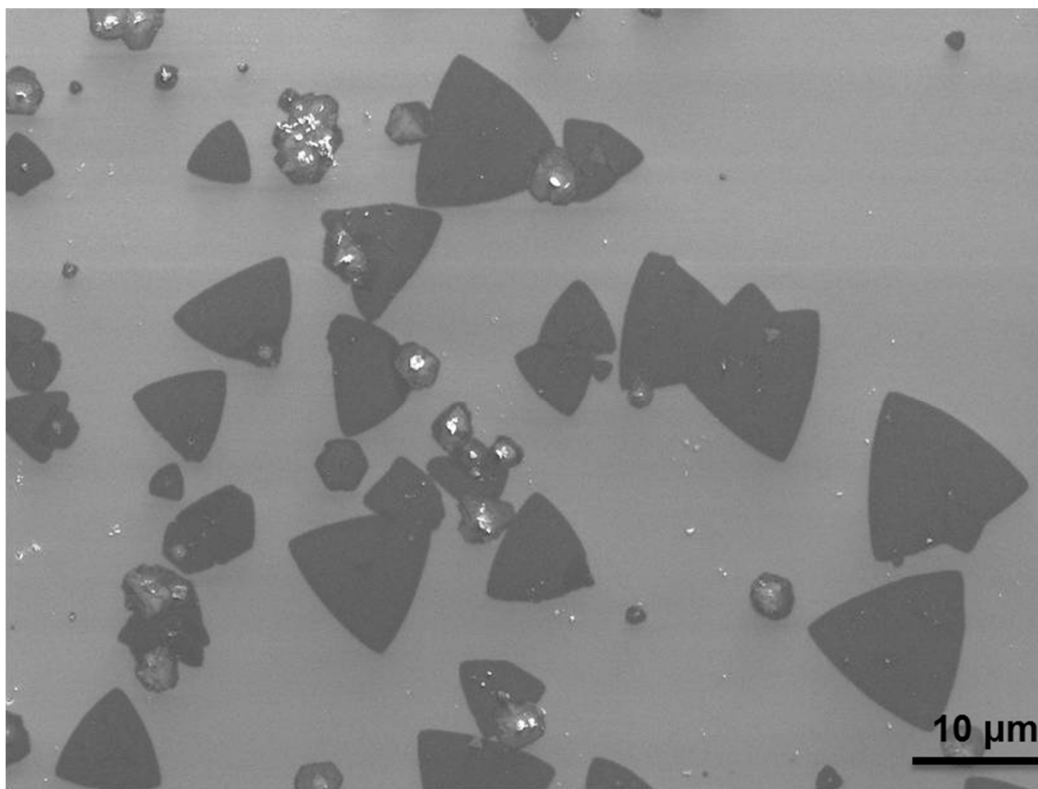


Figure S1. SEM image of as grown WS₂ islands directly on SiO₂/Si substrate by LPCVD. The triangular islands with single contrast correspond to monolayer, whereas the islands containing one, two or more epitaxial layers at their interior with multiple contrasts correspond to bilayer, multilayer and bulk WS₂, respectively.

2. AFM profiles of WS₂ layers

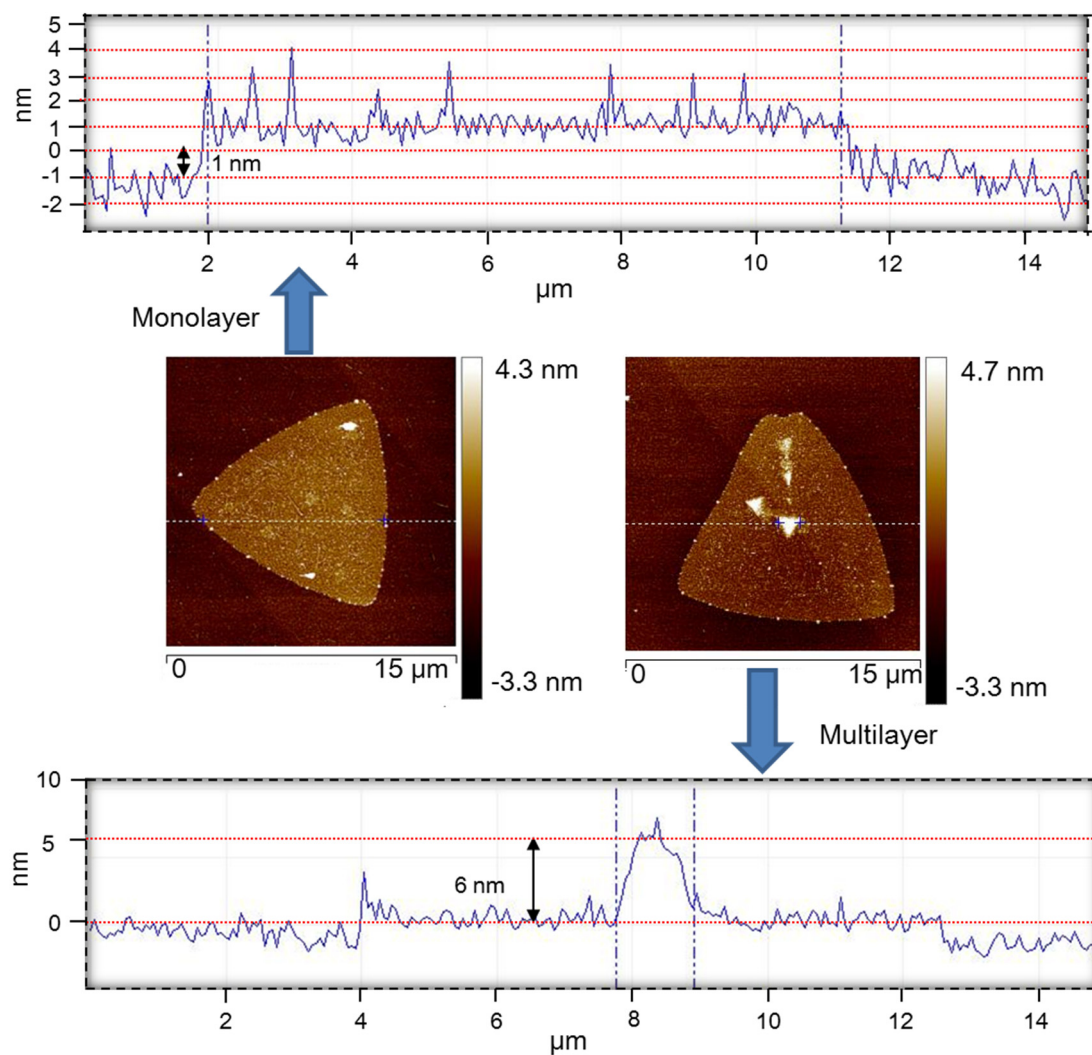


Figure S2. AFM images and height profiles of WS₂ layers. A height of 1 nm and 6 nm in the marked region along y-axis revealing the positions of one and multi WS₂ layers.

3. Electronic band structure calculation using DFT

In order to understand the electronic band structure of the WS₂ layers, the pseudo potential density functional SIESTA package was used for calculations¹⁻⁴ with the local density approximation (LDA) representing the exchange correlation potential and with an energy mesh cutoff of 150 Ry. Optimization of initial experimental structures was performed using analytical energy gradient with respect to atomic coordinates and unit cell parameters. We have used a supercell with dimensions equal to the calculated lattice parameters (a and c) for the band gap calculations of 2H WS₂, however a 13°Å vacuum region was used for the calculations of 1H-WS₂ to isolate the single layer along the c axis and ensure no interactions took place between the layers, making it effectively an isolated 2D layer. The Brillouin zone was sampled with a grid of 5×5×1 k-points within the Monkhorst-Pack scheme.⁵ Band structures were calculated along the high symmetry points using the path Γ -M-K- Γ .

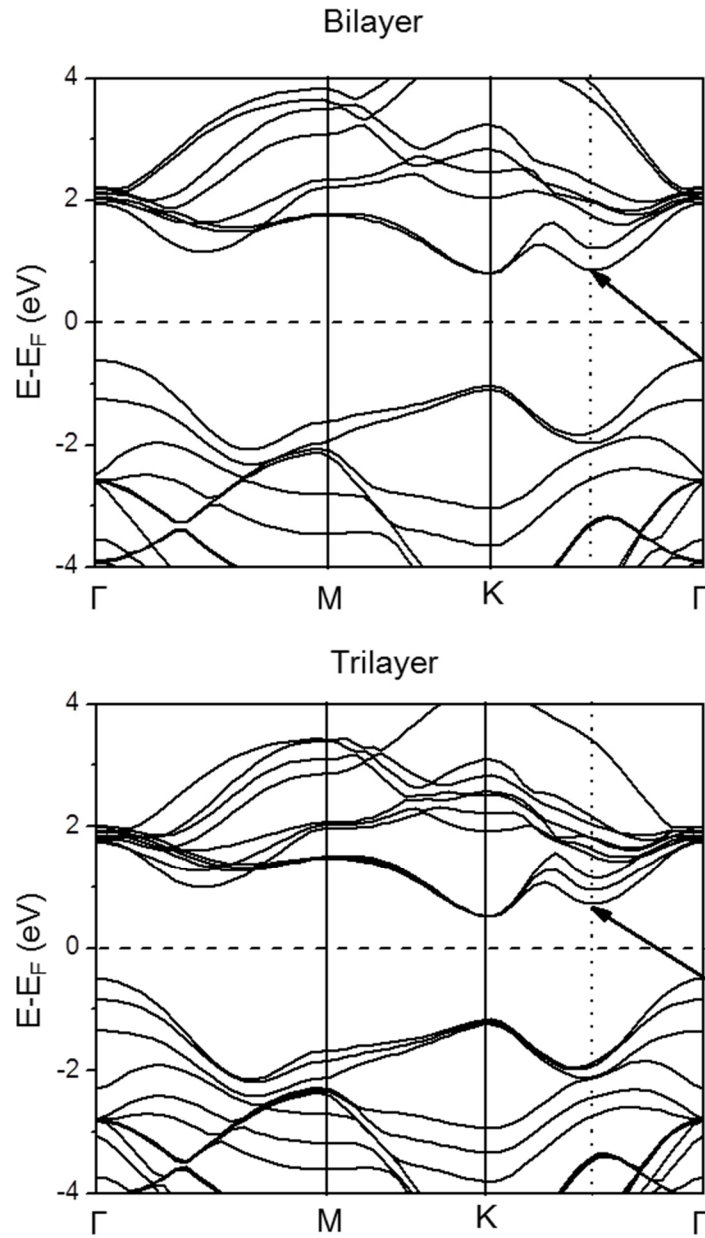


Figure S3. Electronic band structure of bilayer and trilayer WS₂ showing splitting of valence band edge into two and three at K point. The arrow indicates the smallest value of the indirect band gap, which originates from the transition between top of valence band situated at Γ to the bottom of conduction band halfway between Γ and K points. The Fermi level is set at 0 eV.

4. First order derivative of optical conductivity for monolayer WS₂

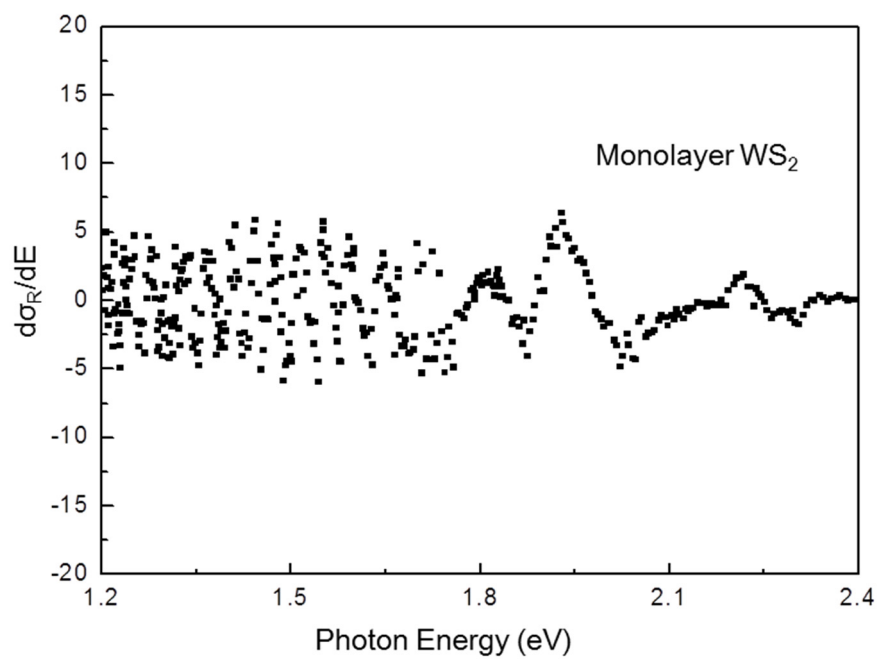


Figure S4. First order derivative of real part of optical conductivity for monolayer WS₂.

5. LPCVD growth of WS₂ films on SiO₂/Si substrates

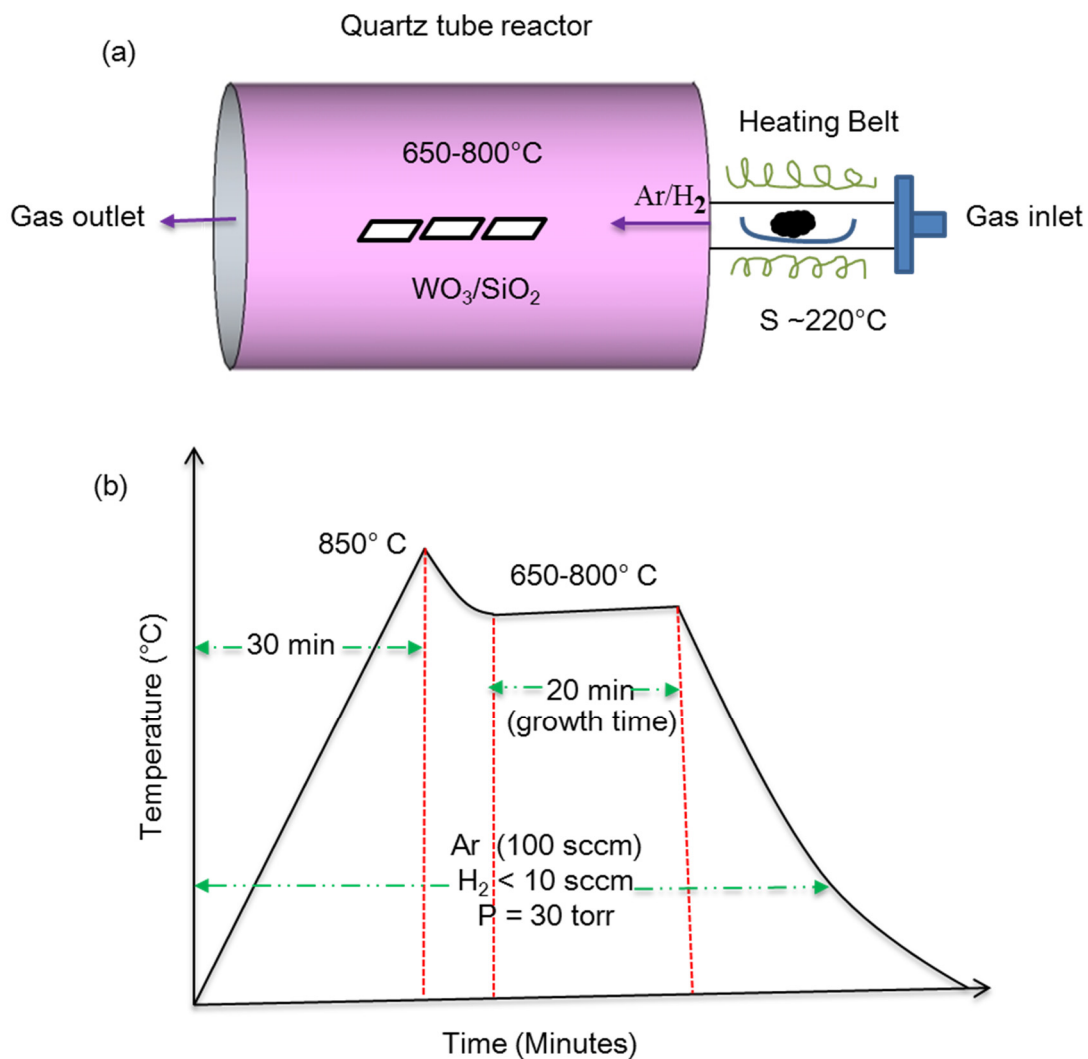


Figure S5 (a) Schematic of the experimental setup used for LPCVD growth of WS₂ films. **(b)** Growth parameters including temperature ramp used for the sulfurization experiments.

References and Notes

- (1) Quantum Wise A/S, "Atomistix Tool Kit", **2010**, Ch. 10.8.2.
- (2) Brandbyge, M.; Mozos, J.; Ordejon, P.; Taylor, J.; Stokbro, K. Density-Functional Method for Nonequilibrium Electron Transport. *Phys. Rev. B* **2002**, *65*, 165401.
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- (5) Monkhorst, H. J.; Pack, J. D. Special Points for Brillouin-Zone Integrations. *Phys. Rev. B* **1976**, *13*, 5188-5192.